


<b>Search Notes</b> 	<b>Application/Control No.</b> 10560447	<b>Applicant(s)/Patent Under Reexamination</b> HESEN ET AL.
	<b>Examiner</b> Chhaya, Swapneel	<b>Art Unit</b> 2822

SEARCHED			
Class	Subclass	Date	Examiner
257	667-677	7/18/2007	Swapneel Chhaya
438	110-114, 123	7/18/2007	Swapneel Chhaya

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Kiesha Rose	7/18/2007	Swapneel Chhaya

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner